

## Atomic-Scale Characterization and Dynamics of Two-dimensional In-Se Materials

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Semiconductors are currently being investigated as potential candidates for optoelectronic and phase change memory devices. Among several III-VI semiconductors, In-Se systems are an interesting type of materials due to their multiple phases and excellent optical properties. For example,  $\text{In}_2\text{Se}_3$  is a direct bandgap material with a layered structure. There are at least five different phases of  $\text{In}_2\text{Se}_3$  ( $\alpha$ ,  $\beta$ ,  $\gamma$ ,  $\delta$ , and  $\kappa$ ). The  $\alpha$  and  $\beta$  -phases can crystallize in both  $\alpha(3R)$  and  $\alpha(2H)$  crystal structures while  $\gamma$  -phase has a defective wurtzite structure. The  $\kappa$ -phase is reported to have a structure more similar to the  $\alpha$ -phase with larger unit cell. On the other hand,  $\text{InSe}$  also has several different phases, which hold substantial potential device applications.

For the suitability of device applications, it is important to have single phase materials which is still a great challenge because different phases of  $\text{In}_2\text{Se}_3$  can co-exist with each other. We investigate how the growth temperature, fluxes and type of substrates ( $\text{GaAs}(100)$ ,  $\text{GaAs}(111)$  A and Mica) influence the growth of  $\text{In}_2\text{Se}_3$  and find the optimum parameters for obtaining phase controlled  $\text{In}_2\text{Se}_3$  by using molecular beam epitaxy (MBE). We have found that Se-rich and high temperatures favour growth of  $\beta$  phase  $\text{In}_2\text{Se}_3$  while  $\gamma$  phase is obtained in In-rich conditions and low temperatures on  $\text{GaAs}(100)$  substrates. Within the same parameter range,  $\gamma$  phase was predominant on  $\text{GaAs}(111)$  A substrates. We are now combining the state-of-the-art scanning transmission electron microscopy (STEM) with density functional theory (DFT) calculations to systematically investigate atomic structure of the grown  $\text{In}_2\text{Se}_3$  and the possible defects in the material. Moreover, we also conduct in-situ TEM and STEM study of 2D  $\text{InSe}$  materials upon heating and will present some

interesting direct in-situ observations. Optoelectronic semiconductors are progressively significant in applications extending from lighting to detecting and inexhaustible energy.<sup>1-16</sup> It is an exceptionally expansive field which alludes to the examination and utilization of electronic gadgets that emanate, identify, and control light. When arranged into gadgets, two-dimensional materials show incredible optoelectronic attributes with ultrahigh optical addition, controllable range affectability, enormous photoreponse transfer speed, and impressive light-to-current change effectiveness. Photoluminescence (PL) is one of the most significant optical properties of optoelectronic semiconductors and generally emerges attributable to different physical phenomena. PL emanation force relies upon the diminishing in the grouping of imperfections, for example, point surrenders including opportunities, dopants, and adatoms, and line deformities, for example, grain limits, which fill in as option nonradiative ways that enormously impact the optical properties of the optoelectronic semiconductors, including 2D materials. Considering the expected uses of two-dimensional material (2D) in gadgets and optoelectronics, the sorts of imperfections and their consequences for the properties of 2D materials should be concentrated in detail. To accomplish this objective, examining the imperfections with nuclear goals is indispensable. Transmission electron microscopy (TEM) is a flexible instrument with various working modes that can describe the structure, science, and electron conditions of 2D materials abandons at the nuclear scale. TEM is a cutting edge innovation that is broadly utilized for the portrayal of morphology, structure, and synthesis of materials with nuclear resolution. The TEM with flexible portrayal modes is an amazing asset that

has been generally applied in materials science and optics science. By exploiting the short frequency of an electron beam, the goals have been expanded to sub-angstrom. Multifunctional TEM could test an example in various modes, for example, diffraction mode, picture mode, and filtering transmission electron microscopy (STEM) mode. The power of the STEM is corresponding to the nuclear number  $Z$  and the thickness of the sample, like that of the mass-thickness differentiate. STEM could be utilized to consider the science and morphology of an example. The explanatory devices, for example, electron vitality misfortune spectroscopy (EELS) and energy-dispersive X-ray spectroscopy (EDX) further stretch out the capacity of TEM to electron state and synthetic investigation, individually.

In this survey, the spoke to uses of TEM for the portrayal of inherent photoluminescence properties of two-dimensional materials, for example, imperfection type and grain limit that effectively affect photoluminescence qualities. The settled structure and science of two-dimensional materials with nuclear goals give a profound comprehension of relations among structure and property, which is significant for its planning, preparing, and application for the future optoelectronic devices.

2D materials with layered structure are stacking with monolayers by powerless van der Waals (vdW) powers. The frail interlayer power can be broken effectively into monolayers or not many layers by a few strategies like micromechanical cleavage, sonication, intercalation-assisted peeling, etc. Another technique is to straightforwardly develop single or barely any layer 2D materials, for example, concoction fume statement (CVD). Single or hardly any layer 2D materials with solid in-plane soundness, nearness of band-

gap, enormous exciton restricting energies, straightforwardness and adaptability can make it plausible to separate, blend and match to make different heterostructure without limitations of cross section coordinating and preparing similarity. Two dimensional material is building square of opto-device. By stacking of the 2D materials, planar diode, dual-gated structures vdW heterostructure diodes, semifloating entryway memories, top-gate field-effect transistors,<sup>53</sup> and infrared memory gadgets can be designed, as appeared This resembles Lego squares. Deformities are the natural properties in the 2D materials, it is imperative to consider the connection among imperfections and opto-characterization, for example, point defects,<sup>65-70</sup> line defects, and heterostructures. Although, the comprehension of imperfections in customary semiconductors is entrenched and the deformities database is moderately finished, absconds in 2D semiconductors, particularly the recently rising monolayer semiconducting change metal dichalcogenides (TMDs), are missing of study This survey is planned to investigate the crucial instrument among abandons and photoluminescence in 2D materials. The inherent connections among the precious stone structures, concoction organizations, and electronic structures of 2D materials are portrayed by TEM innovation. The change of band hole of 2D materials by dopants is a vital route for band hole building of semiconductive materials in novel nanoelectronics and optoelectronics gadgets. Be that as it may, the dopants in have TMDs gem cross sections is difficult to find and recognize because of its nuclear size. The Z-contrast STEM imaging innovation by methods for TEM can distinguish the structure as well as substance piece atom-by-atom.